Special Topics on Basic EECS I VLSI Devices Lecture 4

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A special case

- Sometimes, $f(\mathbf{k})$ depends on only the energy, f(E).
 - -In such a case, the electron density can be written as

$$n = \frac{1}{(2\pi)^3} \iiint_{\substack{Entire\\ \mathbf{k} \ space}} f(\mathbf{k}) dk_x dk_y dk_z = \int_{E_c} N(E) f(E) dE$$

~ Taur, Eq. (2.7)

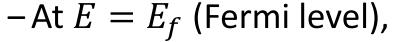
- When do we have f(E), instead of $f(\mathbf{k})$?
- -The equilibrium state is a typical example.

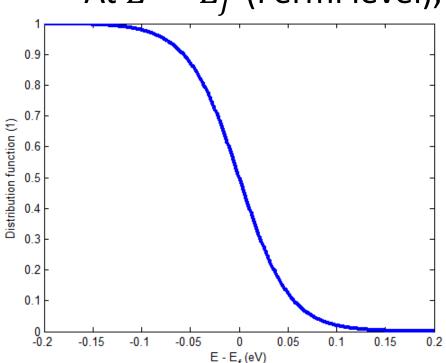
Fermi-Dirac distribution

At equilibrium, the Fermi-Dirac distribution holds

$$f_D(E) = \frac{1}{1 + \exp\left(\frac{E - E_f}{k_B T}\right)}$$

Taur, Eq. (2.4)

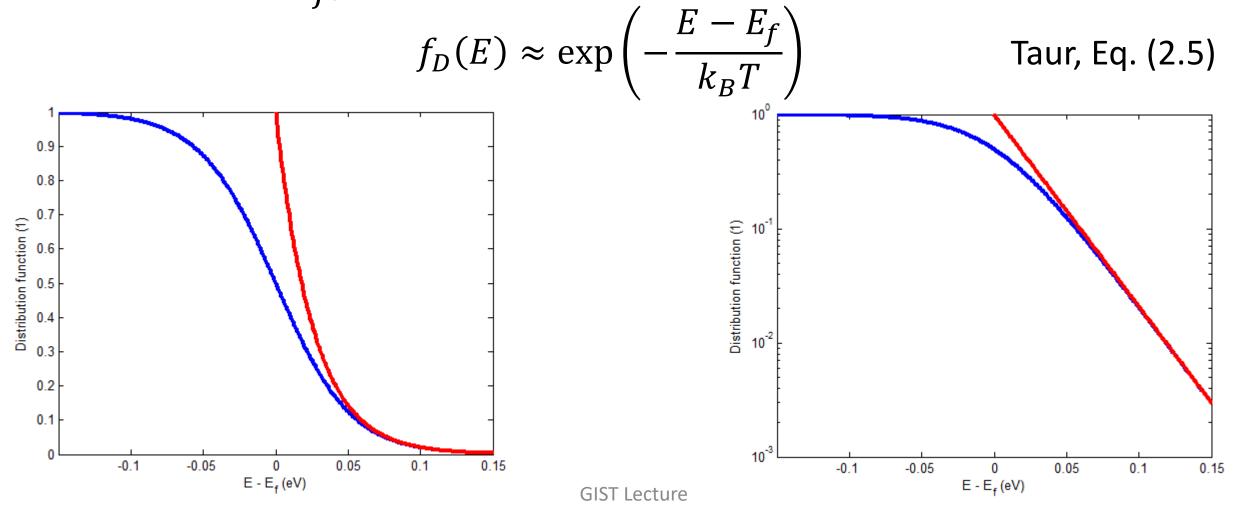




$$f_D(E_f) = \frac{1}{2}$$

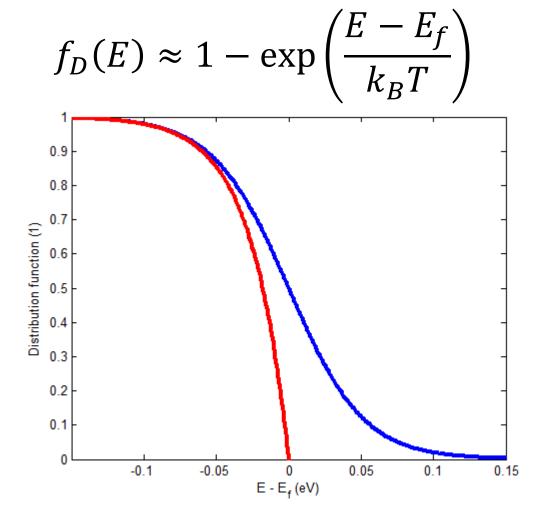
Boltzmann limit

• When $E > E_f$,



Another Boltzmann limit

• When $E < E_f$,



Taur, Eq. (2.6)

Carrier concentration (Electron)

Recall that

Spin and valley degeneracy

$$n = \int N(E)f(E)dE$$

$$N(E) = (2g)\frac{4\pi}{h^3}(2m_l m_t^2)^{0.5}(E - E_c)^{0.5}$$

$$f_D(E) = \exp\left(-\frac{E - E_f}{k_B T}\right)$$

- Collecting them all,

$$n = \frac{8\pi g}{h^3} (2m_l m_t^2)^{0.5} \int_{E_c}^{\infty} (E - E_c)^{0.5} \exp\left(-\frac{E - E_f}{k_B T}\right) dE$$

Taur, Eq. (2.8)

Manipulation

It is found that

$$n = \frac{8\pi g}{h^3} (2m_l m_t^2)^{0.5} \exp\left(-\frac{E_c - E_f}{k_B T}\right)$$

$$\times \int_{E_c} (E - E_c)^{0.5} \exp\left(-\frac{E - E_c}{k_B T}\right) dE$$

-Integral can be evaluated as

$$\int_{E_c}^{3} (E - E_c)^{0.5} \exp\left(-\frac{E - E_c}{k_B T}\right) dE = (k_B T)^{1.5} \int_{0}^{3} z^{0.5} \exp(-z) dz$$

$$= (k_B T)^{1.5} \frac{\sqrt{\pi}}{2}$$
GIST Lecture

Effective DOS

 N_c (cm⁻³) N_{ν} (cm⁻³) 2.8x10¹⁹ Silicon 1.04×10^{19} $4.7x10^{17}$ $7.0x10^{18}$ Gallium arsenide $6.0x10^{18}$ Germanium 1.04×10^{19}

Now we know that

$$n=2g\left(rac{2\pi k_BT}{h^2}
ight)^{1.5} (m_l m_t^2)^{0.5} \exp\left(-rac{E_c-E_f}{k_BT}
ight)$$
 (Hu's boo

 N_c and N_v (Hu's book)

- With the effective DOS,

Dimension?
$$N_c = 2g \left(\frac{2\pi k_B T}{h^2}\right)^{1.5} (m_l m_t^2)^{0.5}$$

Taur, Eq. (2.10)

-The electron density can be simply written as

$$n = N_c \exp\left(-\frac{E_c - E_f}{k_B T}\right)$$

Taur, Eq. (2.9)

– Following a similar derivation, $p = N_v \exp\left(\frac{E_v - E_f}{k_B T}\right)$

Taur, Eq. (2.11)

Intrinsic carrier concentration

• In this case, n=p. Then, what is E_f ?

$$N_c \exp\left(-\frac{E_c - E_f}{k_B T}\right) = N_v \exp\left(\frac{E_v - E_f}{k_B T}\right)$$

- From the above equation,

$$E_f = \frac{E_c + E_v}{2} - \frac{k_B T}{2} \ln \frac{N_c}{N_v}$$

Taur, Eq. (2.12)

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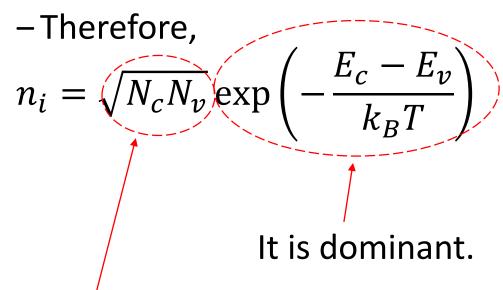
- This energy level is called the intrinsic Fermi level, E_i .
- -In this case,

$$n=p=n_i=\sqrt{N_cN_v}\exp\left(-rac{E_c-E_v}{k_BT}
ight)$$
 Taur, Eq. (2.13)

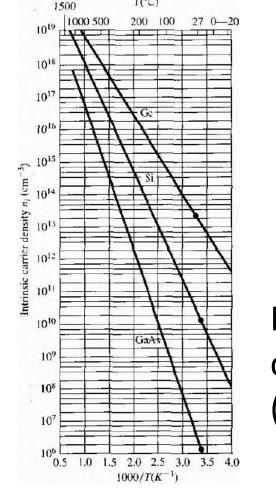
Its temperature dependence

• Recall that $N_c=2g\left(\frac{2\pi k_BT}{h^2}\right)^{1.5}(m_lm_t^2)^{0.5}$. (N_v has a similar

form.)



 $T^{1.5}$, but it is not dominant.



Intrinsic carrier density (Neamen's book)

Using the intrinsic carrier density,

Carrier densities are expressed as

$$n=n_i \exp\left(-rac{E_i-E_f}{k_BT}
ight)$$
 Taur, Eq. (2.14) $p=n_i \exp\left(rac{E_i-E_f}{k_BT}
ight)$ Taur, Eq. (2.15)

- A useful, general relationship is that the product

$$np = n_i^2$$

Taur, Eq. (2.16)

in equilibrium is a constant, independent of the Fermi level position.

Recall that

- We have 7 X 10²³ electrons/cm³ in Si.
 - -At 300 K, only $^{\sim}$ 1.4 X 10^{10} electrons/cm 3 can be found in the conduction band. Only a single elelctron among 5 X 10^{13} electrons occupies the conduction band.
 - -There are 4 moonwalkers among 8.1 X 10⁹ people.



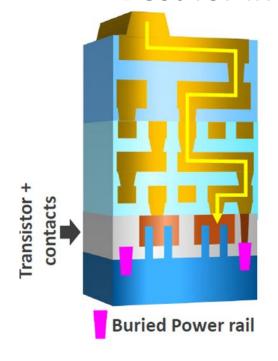




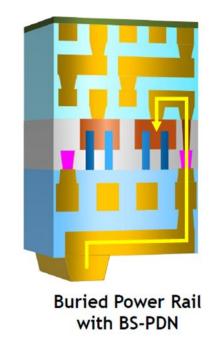


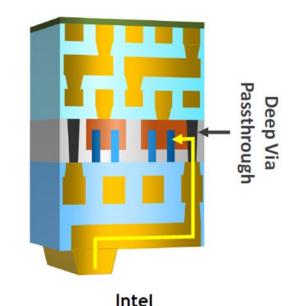
Copper (A good conductor)

- How many conduction electrons in 1 cm³?
 - -Cu: ~ 8.5 X 10^{22} cm⁻³
 - Best for interconnect



Buried Power Rail without BS-PDN



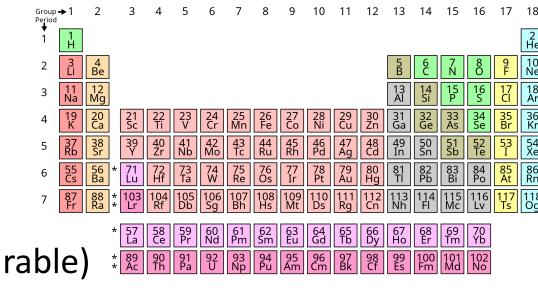


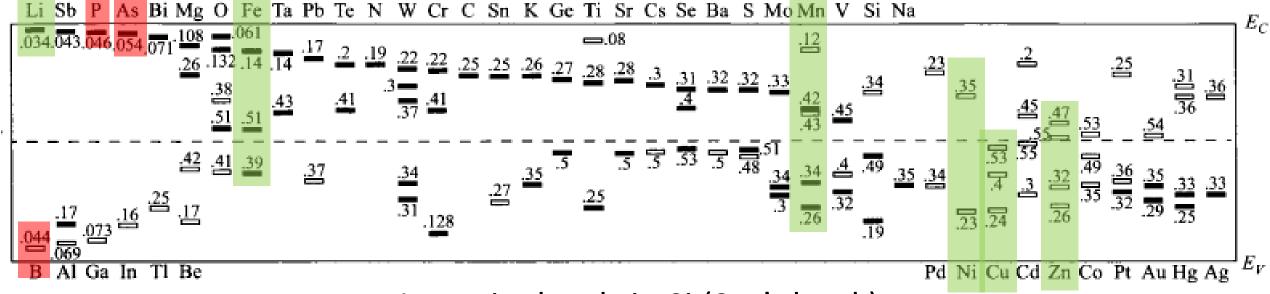
PowerVia

Various ways to supply the power to transistors (Intel, VLSI 2023)

Dopants

- 5 X 10²⁰ impurities / cm³ is 1 % of Si.
 - Find As, P, and B.
 - Find Fe, Cu, Li, Zn, Mn, and Ni. (Undesirable)





Impurity levels in Si (Sze's book)

Thank you!